

Applicant(s): Maria E. de Leon et al.

Docket No.:

19245

Unknown

Serial No.:

10/632,258

Group:

3751

Filed:

July 31, 2003

Examiner:

nitial		Doc. No.	Date	Name	Clas		Subclas	Filing
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Khoa D. Huynh

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m	A1	Exhibit A - 1 photogra Kit," sold by Kimberly application.	ph showing -Clark Ltd. i	top view of a splash mat pr n the United Kingdom prior t	ovided in a to the filing	"Potty Trainin date of the pr	g Starte esent	er ———
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